

NUMBER GS-12-641	TYPE PRODUCT SPECIFICATION		
TITLE USB Micro B A/B CONNECTOR		PAGE 1 of 8	REVISION C
		AUTHORIZED BY LQ.Lei	DATE 10/28/15
CLASSIFICATION UNRESTRICTED			

1.0 GENERAL

This specification defines the performance, tests and quality requirements for the USB Micro B A/B connectors.

This document is composed of the following sections.

General

Scope

Applicable Documents

Requirements

- ✧ Design and Construction
- ✧ Material
- ✧ Finish

Test Methods and Requirements

Test Plan

Applicable Part Number and Product Drawing

2.0 SCOPE

This specification is applicable to the termination characteristics of the USB Micro B A/B family of products which provides interconnection of computer peripherals.

3.0 APPLICABLE DOCUMENTS

3.1 Military Standards:

- 3.1.1 MIL-STD-202F: Test methods for electronic and electrical component parts.
- 3.1.2 MIL-STD-1344A: Test methods for electrical connectors.

3.2 Industry Specification/Other Standards:

- 3.2.1 UL-94: Tests for flammability of plastic materials.
- 3.2.2 EIA 364: Electrical connector/socket test procedures including environmental classifications.
- 3.2.3 Micro-USB: Universal Serial Bus Specification.

4.0 REQUIREMENT

4.1 Design and Construction:

Connectors shall be of the design construction and physical dimensions specified on the applicable product drawing and shall be capable of meeting the qualification test requirements specified herein.

4.2 Materials

4.2.1 Housing:

- ✧ The insulators shall be rated flame retardant 94V-0 in accordance with UL-94.

4.2.2 Terminal:

- ✧ Copper Alloy.

4.2.3 Shell:

- ✧ Stainless steel.

4.3 Finish:

The finish for applicable components shall be specified on the applicable product drawing

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- 4.3.1 Contact Area: Selective gold plating with Nickel under-plated.
- 4.3.2 Solder Tail Area: Gold with Nickel under-plated.
- 4.3.3 Shell: Nickel plating or Sn plating.

4.4 Operating Condition:
Operating temperature:-30°C~80°C.

5.0 TEST METHODS AND REQUIREMENTS:

5.1 Examination of product:

Item	Test Description	Test Methods	Requirement
5.1.1	Examination of product (Outward Appearance Structure)	EIA 364-18 Shall be confirmed with eyes in accordance with each drawing. Shall be confirmed by using proper measuring instruments.	1).Outward appearance shall be good without such injurious problem. 2).Structure shall be meet the design and dimensional requirements of drawing.

5.2 Electrical Performance:

Item	Test Description	Test Methods	Requirement
5.2.1	Low Level Contact Resistance	EIA 364-23 (or MIL-STD-1344A, Method 3002.1, Test Condition B) Subject mated contacts assembled in housing to 20mV maximum open circuit at 100 mA maximum	1).Initial: 30 mΩ Maximum 2).After test: delta 10 mΩ Maximum change
5.2.2	Insulation Resistance	EIA 364-21 (or MIL-STD-202F, Method 302, Test Condition B) Test between adjacent contacts of mated and unmated connector assemblies.	1).Initial: 1,000MΩ Minimum 2).After test: 100MΩ Minimum
5.2.3	Dielectric Withstanding Voltage	EIA 364-20 (or MIL-STD-202F, Method 301, Test Condition B) Test between adjacent contacts of mated and unmated connector assemblies.	100 V AC for one minute at sea level 1).No flashover or insulation breakdown 2).Leakage current: 0.5mA (JPC:5mA)Maximum.

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5.2.4	Contact Capacitance	EIA 364-30 Test between adjacent circuits of unmated connector at 1 KHz.	2 pF Maximum per Contact
5.2.5	Contact Current Rating	EIA 364-70 Method 1 When measured at an ambient temperature of 25°. With Power applied to the contacts, the ΔT shall not exceed 30°C at any point in the USB connector under test.	1). Signal contacts only (2, 3 and 4): 1A (MIN) per single contact. 2). With power applied contacts (1, 5): 1.8A for power contacts 1 and 5 at the same time 0.5A for contact 2, 3 and 4.

5.3 Mechanical Performance:

Item	Test Description	Test Methods	Requirement
5.3.1	Random Vibration	EIA 364-28 Test Condition V Test Letter A , (or MIL-STD-202F, Method 214, Test Condition 1, Test Letter A) Subject mated connectors to 5.35 G's rms. Fifteen minutes in each of three mutually perpendicular planes.	1).No discontinuities of 1micro sec or longer duration 2).Shall meet visual requirement, show no physical damage. 3).Shall meet requirements of additional tests as specified in TEST SEQUENCE in Section 6
5.3.2	Physical Shock	EIA 364-27 Test Condition H (or MIL-STD-202F, Method 214B) Subject mated connectors to 30G's half-sine shock pulses of 11ms duration. Three shocks in each direction applied along three mutually perpendicular planes, 18 total shock.	1).No discontinuities of 1 μ sec or longer duration 2).Shall meet visual requirement, show no physical damage. 3).Shall meet requirements of additional tests as specified in TEST SEQUENCE in Section 6
5.3.3	Durability	EIA 364-09 Mate and unmate Connector assemblies for 10,000cycles at maximum rated of 200 cycles per hour.	1).Shall meet visual requirement, show no physical damage. 2).Shall meet requirements of additional tests as specified in TEST SEQUENCE in Section 6
5.3.4	Connector Insertion Force	EIA 364-13 Shall be measured with tension gauge	35N (MAX)

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		or tension tester. Measure force necessary to mate assemblies at maximum rate of 12.5mm (or 0.492") per minute.	
5.3.5	Connector Extraction Force	EIA 364-13 Shall be measured with tension gauge or tension tester. Measure force necessary to mate assemblies at maximum rate of 12.5mm (or 0.492") per minute.	8N (MIN) after 10,000 insertion/extraction cycles.
5.3.6	Cable Pull-Out Force	EIA 364-38 Apply axial load to the cable for 1 minute. Shall be measured with tension gauge or tension tester.	1).25N for plug, 50N for receptacle 2).Cable or connector shall be not dislodge from cable crimp.

5.4 Environmental Performance:

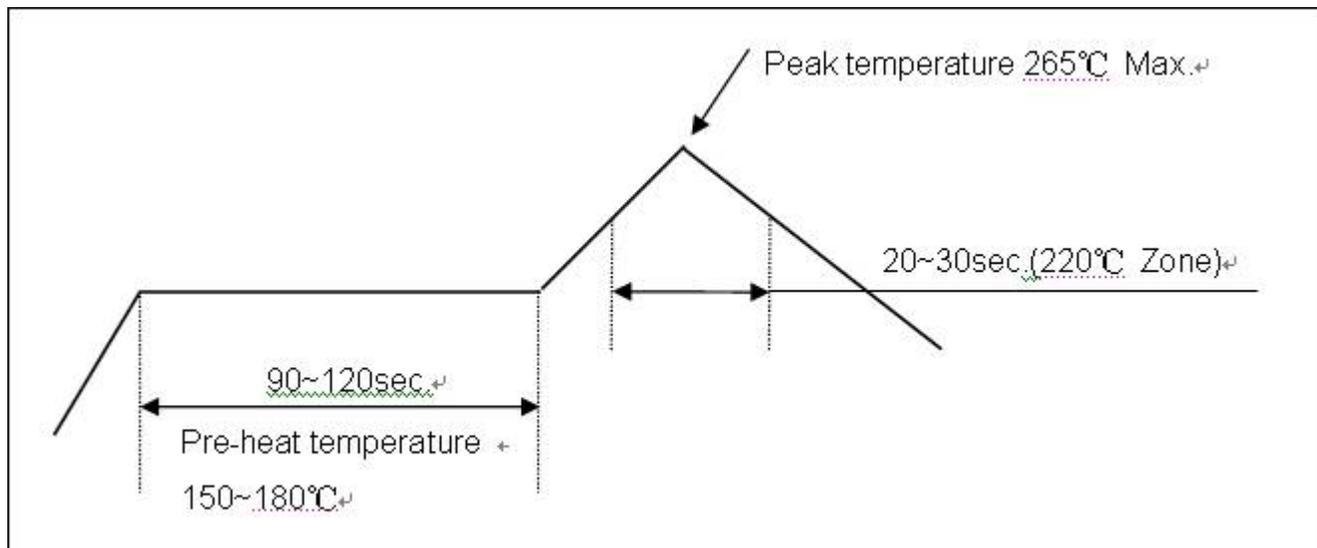
Item	Test Description	Test Methods	Requirement
5.4.1	Thermal Shock	EIA 364-32, Test Condition I, (or MIL-202F, Method 107G Condition A.) Subject mated connectors to 10 cycles between -55°C to +85°C.	1).Shall meet visual requirement, show no physical damage. 2).Shall meet requirements of additional tests as specified in TEST SEQUENCE in Section 6
5.4.2	Humidity	EIA 364-31, Test Condition A Method III, (or MIL-202F, Method 103B Test Condition B.)	1).Shall meet visual requirement, show no physical damage. 2).Shall meet requirements of

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		Subject mated connectors to 168 Hours (seven complete cycles)	additional tests as specified in TEST SEQUENCE in Section 6
5.4.3	Temperature Life	EIA 364-17 Test Condition 3 Method B. Subject mated connectors to temperature life at 85□ for 96 hours	1). Shall meet visual requirement, show no physical damage. 2). Shall meet requirements of additional tests as specified in TEST SEQUENCE in Section 6
5.4.4	Solderability	EIA 364-52 After one hour steam aging. Or MIL-STD-202F, Method 208G. 256degC for 5 seconds.(Nickel Plating for Shell)	The surface of the portion to be soldered shall at least 95% covered with new solder coating, as specified in Category 2.

TEMPERATURE PROFILE



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6.0 TEST PLAN:

TEST ITEM	PARA.	TEST GROUP					
		A	B	C	D	E	
		TEST SEQUENCE					
Examination of Product	5.1.1	1,11	1,5	1,9	1,4	1,3	
L/L Contact Resistance	5.2.1	4,8	2,4				
Insulation Resistance	5.2.2			3,7			
Dielectric Withstand Voltage	5.2.3			4,8			
Contact Capacitance	5.2.4			2			
Contact Current Rating	5.2.5				2		
Random Vibration	5.3.1	6					
Physical Shock	5.3.2	7					
Durability	5.3.3	5					
Insertion Force	5.3.4	2,9					
Extraction Force	5.3.5	3,10					
Cable Pull-Out Force	5.3.6					2	
Thermal Shock	5.4.1			5			
Humidity	5.4.2			6			
Temperature Life	5.4.3		3				
Solderability	5.4.4				3		
Sample Size		5	5	5	5	5	

Note:

- a. Samples shall be prepared in accordance with applicable manufacturer's instructions and shall be selected at random from current production.

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- b. The numbers in the table indicate sequence in which tests are performed.
- c. Precondition samples with 10 cycles durability.
- d. All the tests shall be performed in the sequence, indicated by the number in the columns.

6.0 APPLICABLE PART NUMBER & PRODUCT DRAWING:

Part Number	Product Description	Drawing Number
10104110-0001LF	Micro USB B Receptacle 5pos, R/A, SMT Type	10104110
10104111-0001LF	Micro A/B Receptacle 5pos, R/A, SMT Type	10104111
10104109-0001LF	Micro USB B Plug 5pos, SM Type	10104109
10103592-0001LF	Micro USB B Receptacle 5pos, R/A, Reverse	10103592
10103593-0001LF	Micro USB B Receptacle 5pos, R/A, Mid-Mount	10103593
10103594-0001LF	Micro USB B Receptacle 5pos, R/A	10103594
10118192-0001LF	Micro USB B Receptacle 5pos, R/A, SMT Type	10118192
10118193-0001LF	Micro USB B Receptacle 5pos, R/A, SMT Type	10118193
10118194-0001LF	Micro USB B Receptacle 5pos, R/A, SMT Type	10118194

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Revision Record

Revision	Page	Description	ECR no	Date
A	All	New release	T10-0002	3/9/2010
B	Page7	Add new part numbers	ELX-T-007202	10/21/11
C	Page2	Add TEMPERATURE PROFILE	ELX-N-18486	
10/28/15				

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